

INFORMATION DISCLOSURE
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10/701,181

APPLICANT

PARKER et al

FILING DATE

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(use several sheets if necessary)

U.S. PATENT DOCUMENTS

EXAMINER INITIAL	DOCUMENT NUMBER	DATE	NAME	FILING DATE		
				CLASS	SUBCLASS	IF APPROPRIATE
SP	6,542,682	4/2003	Cotterete et al			
	6,075,915	6/2000	Koops et al			
	6,631,236	10/2003	Yamada			
	5,961,924	10/1999	Reichert et al			
	6,560,006	5/2003	Sigalas et al			
	2001/0033409	10/2001	Takada			
	6,134,369	10/2000	Kurosawa			
	5,526,449	6/1996	Meade et al			
SP	2002/0150366	10/2002	Loncar et al			
SP	2004/0062505	4/2004	Sugitatsu et al			

FOREIGN PATENT DOCUMENTS

DOCUMENT	DATE	COUNTRY	CLASS	SUBCLASS	TRANSLATION YES	NO

OTHER DOCUMENTS (including Author, Title, Date, Pertinent pages, etc.)

Primak, William, "Refractive Index of Silicon" April 1971, Applied Optics, Vol. 10, Issue 4, 759-763.

*Examiner

Sunny Park

Date Considered

4/3/05

Examiner: Initial if reference considered, whether or not citation is in conformance with MPEP 609; Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to application.